

Notice of References Cited

Application/Control No.

09/863,528

Applicant(s)/Patent Under

Reexamination

NEBERT, DANIEL W.

Examiner

Valarie Bertoglio

Art Unit

1632

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	V	Kroll, 1996, Development, Vol. 122, pages 3173-3183. ✓
	W	Miller-Bertoglio. 2000, Disseration, The Johns Hopkins University, Chapter 3.
	X	Carvan, 1999, Mar. Biotechnol., Vol. 1, pages 155-166. ✓

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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